Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/649,896	LEE, BYEONG-HOON	
Examiner	Art Unit	
George D. Spisich	3616	

	SEAR	CHED	
Class	Subclass	Date	Examiner
280 74	775 493	9/8/05	BAS
-			
update	d rearch	3/2/06	MAS

INTERFERENCE SEA			RFERENCE SEARCHED	
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
		-
·		
		ļ
_		
		
		1